

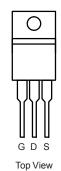
K1296-VB Datasheet N-Channel 60 V (D-S) MOSFET

PRODUCT SUMMARY					
V _{DS} (V)	R _{DS(on)} (Ω)	I _D (A) ^a			
60	0.024 at V _{GS} = 10 V	50			
00	0.028 at V _{GS} = 4.5 V	40			

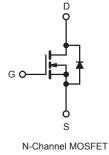
FEATURES

- Halogen-free According to IEC 61249-2-21 Definition
- Surface Mount
- Available in Tape and Reel
- Dynamic dV/dt Rating
- Logic-Level Gate Drive
- Fast Switching
- Compliant to RoHS Directive 2002/95/EC





TO-220AB



ABSOLUTE MAXIMUM RATINGS ($T_C = 25 \text{ °C}$, unless otherwise PARAMETER			SYMBOL	LIMIT	UNIT	
Drain-Source Voltage			V _{DS}	60	V	
Gate-Source Voltage			V _{GS}	± 20		
Continuous Drain Current ^f	V_{GS} at 10 V $T_{C} = 25 °C$ $T_{C} = 100 °C$		I _D	50		
Continuous Drain Current				36	А	
Pulsed Drain Current ^a			I _{DM}	200		
Linear Derating Factor				1.0	W/°C	
Linear Derating Factor (PCB Mount) ^e				0.025		
Single Pulse Avalanche Energy ^b			E _{AS}	400	mJ	
Maximum Power Dissipation $T_{C} = 25 \text{ °C}$		P	150	w		
Maximum Power Dissipation (PCB Mount)e	T _A = 25 °C		P _D	3.7	- VV	
Peak Diode Recovery dV/dt ^c			dV/dt	4.5	V/ns	
Operating Junction and Storage Temperature Range			T _J , T _{stg}	- 55 to + 175	- °C	
Soldering Recommendations (Peak Temperature) ^d	ring Recommendations (Peak Temperature) ^d for 10 s			300 ^d		

Notes

a. Repetitive rating; pulse width limited by maximum junction temperature (see fig. 11). b. $V_{DD} = 25 \text{ V}$, starting $T_J = 25 \text{ °C}$, $L = 179 \text{ }\mu\text{H}$, $R_g = 25 \Omega$, $I_{AS} = 51 \text{ A}$ (see fig. 12). c. $I_{SD} \le 51 \text{ A}$, dl/dt $\le 250 \text{ A/}\mu\text{s}$, $V_{DD} \le V_{DS}$, $T_J \le 175 \text{ °C}$.

e. When mounted on 1" square PCB (FR-4 or G-10 material).

f. Current limited by the package, (die current = 51 A).

d. 1.6 mm from case.

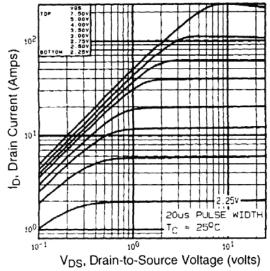


THERMAL RESISTANCE RAT	NGS								
PARAMETER	SYMBOL	TYP		MAX.		UNIT			
Maximum Junction-to-Ambient	R _{thJA}	-	- 62		1				
Maximum Junction-to-Ambient (PCB Mount) ^a	R _{thJA}	-		40		°C/W			
Maximum Junction-to-Case (Drain)	R _{thJC}	- 1.0							
Note a. When mounted on 1" square PCB (FR-4	or G-10 material)). 1							
SPECIFICATIONS (T _J = 25 °C, u	unless otherw	ise noted)							
PARAMETER	SYMBOL	TES	T CONDIT	IONS	MIN.	TYP.	MAX.	UNIT	
Static	•	•			4			<u>,</u>	
Drain-Source Breakdown Voltage	V _{DS}	V _{GS}	= 0, I _D = 25	50 µA	60	-	-	V	
V _{DS} Temperature Coefficient	$\Delta V_{DS}/T_{J}$	Referenc	e to 25 °C,	l _D = 1 mA	-	0.070	-	V/°C	
Gate-Source Threshold Voltage	V _{GS(th)}	V _{DS} =	· V _{GS} , I _D = 2	250 μA	1.0	-	2.5		
Gate-Source Leakage	I _{GSS}		$V_{\rm GS} = \pm 10^{\circ}$		-	-	± 100	nA	
-		$V_{DS} = 60 V, V_{GS} = 0 V$			-	-	25	μA	
Zero Gate Voltage Drain Current	I _{DSS}	$V_{DS} = 48 \text{ V}, V_{GS} = 0 \text{ V}, T_J = 150 \text{ °C}$			-	-	250		
		V _{GS} = 10 V		= 21 A ^b	_	0.024	_	Ω	
Drain-Source On-State Resistance	R _{DS(on)}	V _{GS} = 4.5 V	5	= 15 A ^b	-	0.028	_		
Forward Transconductance	g _{fs}	$V_{DS} = 25 \text{ V}, \text{ I}_{D} = 21 \text{ A}^{\text{b}}$		23	-	-	S		
Dynamic	013	20	, , ,						
Input Capacitance	C _{iss}				_	190			
Output Capacitance	C _{oss}	V _{GS} = 0 V, V _{DS} = 25 V, f = 1.0 MHz, see fig. 5		_	920	_	pF		
Reverse Transfer Capacitance	C _{rss}			_	170	-			
Total Gate Charge	Qg				_	-	66		
Gate-Source Charge	Q _{gs}	$V_{GS} = 5.0 \text{ V} \qquad \begin{array}{c} I_{D} = 51 \text{ A}, V_{DS} = 48 \text{ V}, \\ \text{see fig. 6 and } 13^{\text{b}} \end{array}$		_	-	12	nC		
Gate-Drain Charge	Q _{gd}			_	_	43			
Turn-On Delay Time	t _{d(on)}				_	17	-		
Rise Time	t _r		00.1/			230	_	- ns	
Turn-Off Delay Time			= 30 V, I _D = R _D = 0.56 Ω		_	200	-		
Fall Time	t _{d(off)} t _f	$R_g = 4.6 \ \Omega, R_D = 0.56 \ \Omega$, see fig. 10^b		_	110		-		
Internal Drain Inductance	L _D	Between lead, 6 mm (0.25") from package and center of die contact		-	4.5	_			
Internal Source Inductance	L _S			-	7.5	-	nH		
Drain-Source Body Diode Characteristi				S				I	
Continuous Source-Drain Diode Current		MOSFET sym	bol				50 ^c		
	I _S	showing the integral reverse		-	-		A		
Pulsed Diode Forward Current ^a	I _{SM}	p - n junction diode		-	-	200			
Body Diode Voltage	V _{SD}	$T_{J} = 25 \ ^{\circ}C, I_{S} = 51 \ A, V_{GS} = 0 \ V^{b}$		-	-	2.5	V		
Body Diode Reverse Recovery Time	t _{rr}	T₁=25 °C I⊧	= 51 A. dl/	dt = 100 A/µs ^b	-	130	180	ns	
Body Diode Reverse Recovery Charge	Q _{rr}	., _0 0, 1	e. , , ai,		-	0.84	1.3	μC	
Forward Turn-On Time	t _{on}	Intrinsic tu	rn-on time	is negligible (turn	-on is dor	ninated b	y L _S and	L _D)	

Notes

a. Repetitive rating; pulse width limited by maximum junction temperature (see fig. 11).
b. Pulse width ≤ 300 µs; duty cycle ≤ 2 %.
c. Current limited by the package, (Die Current = 51 A).





TYPICAL CHARACTERISTICS (25 °C, unless otherwise noted)



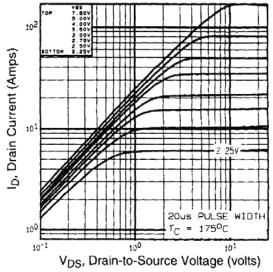
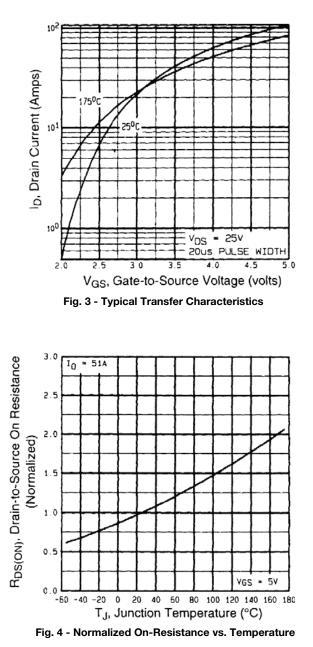


Fig. 2 - Typical Output Characteristics, $T_C = 150$ °C





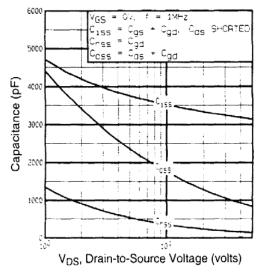


Fig. 5 - Typical Capacitance vs. Drain-to-Source Voltage

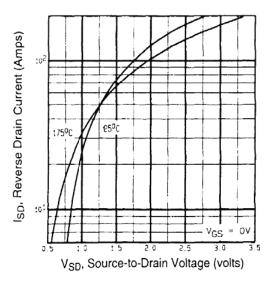


Fig. 7 - Typical Source-Drain Diode Forward Voltage

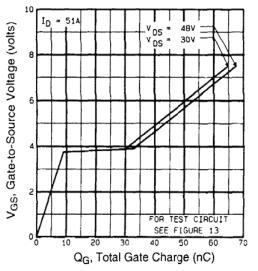
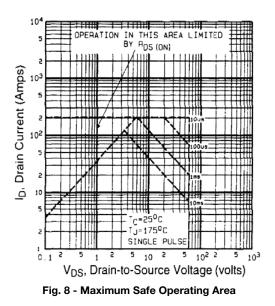


Fig. 6 - Typical Gate Charge vs. Gate-to-Source Voltage





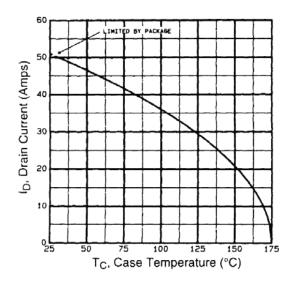


Fig. 9 - Maximum Drain Current vs. Case Temperature

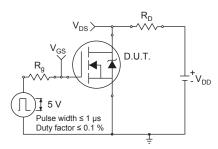


Fig. 10a - Switching Time Test Circuit

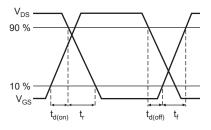
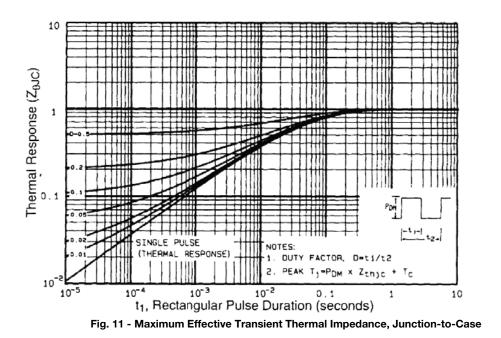


Fig. 10b - Switching Time Waveforms





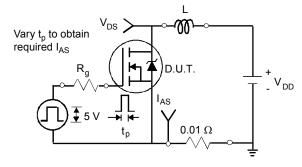


Fig. 12a - Unclamped Inductive Test Circuit

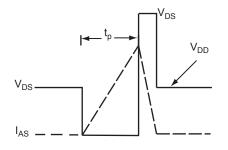


Fig. 12b - Unclamped Inductive Waveforms



Fig. 12c - Maximum Avalanche Energy vs. Drain Current

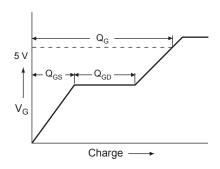


Fig. 13a - Basic Gate Charge Waveform

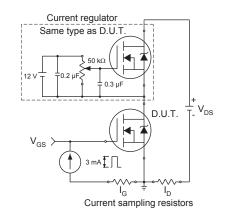
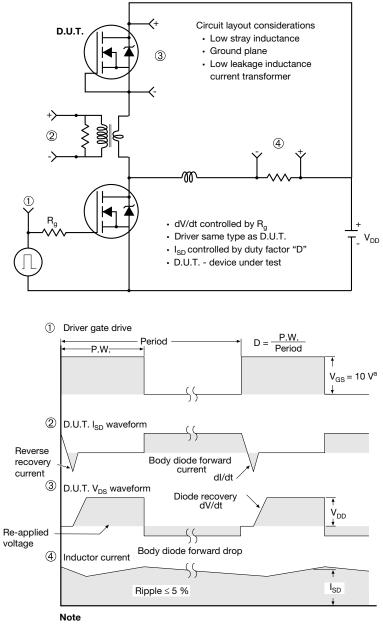


Fig. 13b - Gate Charge Test Circuit



Peak Diode Recovery dV/dt Test Circuit

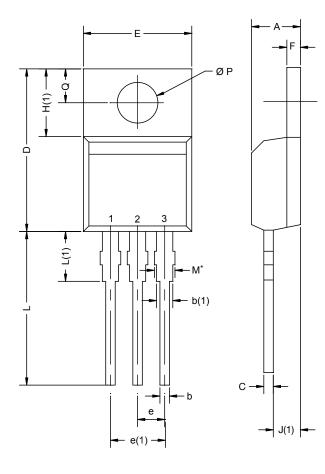


a. V_{GS} = 5 V for logic level devices

Fig. 14 - For N-Channel



TO-220AB



	MILLIN	IETERS	INC	HES	
DIM.	MIN.	MAX.	MIN.	MAX.	
А	4.25	4.65	0.167	0.183	
b	0.69	1.01	0.027	0.040	
b(1)	1.20	1.73	0.047	0.068	
С	0.36	0.61	0.014	0.024	
D	14.85	15.49	0.585	0.610	
Е	10.04	10.51	0.395	0.414	
е	2.41	2.67	0.095	0.105	
e(1)	4.88	5.28	0.192	0.208	
F	1.14	1.40	0.045	0.055	
H(1)	6.09	6.48	0.240	0.255	
J(1)	2.41	2.92	0.095	0.115	
L	13.35	14.02	0.526	0.552	
L(1)	3.32	3.82	0.131	0.150	
ØΡ	3.54	3.94	0.139	0.155	
Q	2.60	3.00	0.102	0.118	
ECN: X12- DWG: 547	0208-Rev. N, 1	08-Oct-12			

Notes

* M = 1.32 mm to 1.62 mm (dimension including protrusion) Heatsink hole for HVM



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